

SMD Shielded Wire Wound Power Inductor

Features

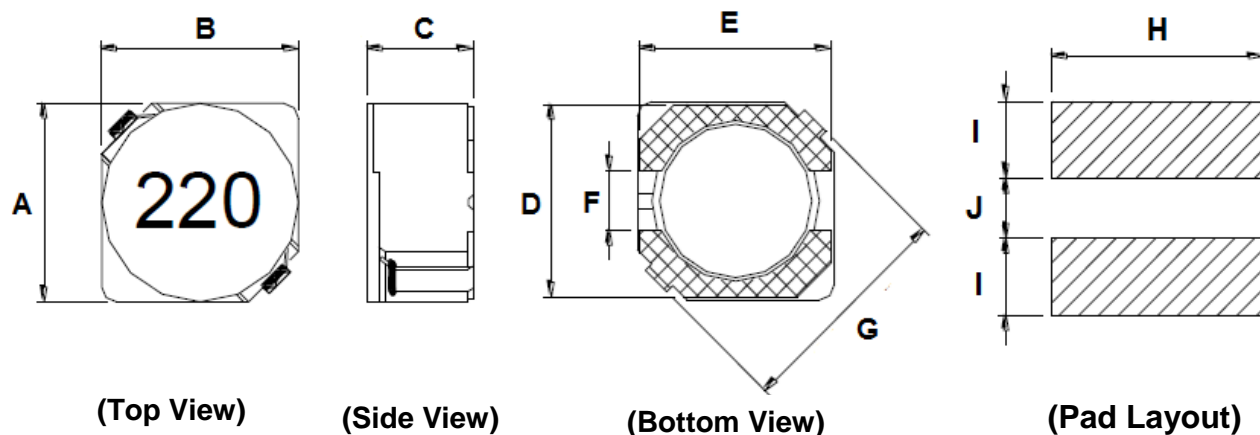
- Magnetically shielded construction
- Compact and thin
- Large current and low DCR
- RoHS Compliant



Applications

- DC-DC converter of portable equipment
- Camcorder, LCD television set, digital camera, notebook

Dimensions



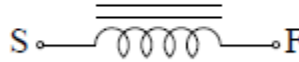
Unit: mm

A Max.	B Max.	C Max.	D Typ.	E Typ.	F Typ.	G Max.	H Typ.	I Typ.	J Typ.
5.0	5.0	3.1	4.5	4.5	1.5	6.9	5.3	1.9	1.5

SMD Shielded Wire Wound Power Inductor

TIS4D28QES Series

Circuit



Material

NO.	Item	Supplier	Material
1	Core	Ferrite Electronic Ind. Co., LTD. or Equiv.	1CDR046028R20-1.8S
2	RI Core	Ferrite Electronic Ind. Co., LTD. or Equiv.	1CRI047024R41S
3	Wire	Pacific Electronics Wire & Co., LTD. or Equiv.	1W2UEW
4	Clip	Lian Cheng Electronics Ironware or Equiv.	1MIS-C04601S
5	Epoxy	Wells Electronic Material (Guangzhou) Co., LTD.	1EEP-A1006 1EEP-B1006
6	Epoxy	Grace Power Polymer Technology Co., LTD.	1EEP-G500
7	Flux	Shenzhen Yuantong Industry Co., LTD. or Equiv.	1EEFL-W809S
8	Solder	Daihui Electronics Chemicals Co., LTD.	1MTIN-Sn0.7Cu-2

Electrical Specifications

Symbol	Description	Value	Unit	Conditions
L	Inductance	0.68 ~ 180	μH	100KHz, 250mV, 25°C
DCR	DC Resistance (max.)	20 ~ 1900	mΩ	25°C
IDC	Rated DC Current (max.) (Note)	0.22 ~ 3.1	A	100KHz, 250mV
Top	Operating Temperature	-40 to 125	°C	-
Tstg	Storage Temperature	-40 to 125	°C	

Note: Lower inductance by 35%

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TIS4D28QES Series

Specifications

Part Number	L (μ H)	Test Freq. (KHz)	DCR (m Ω) Max.	Rated DC Current (A) Max.
TIS4D28QESR68*	0.68	100	20.0	3.10
TIS4D28QES1R0*	1.0		25.5	2.56
TIS4D28QES1R5*	1.5		40.0	2.38
TIS4D28QES1R8*	1.8		37.0	2.20
TIS4D28QES2R2*	2.2		50.5	2.00
TIS4D28QES2R7*	2.7		50.5	1.60
TIS4D28QES3R3*	3.3		58.0	1.57
TIS4D28QES3R9*	3.9		66.5	1.44
TIS4D28QES4R7*	4.7		72.0	1.32
TIS4D28QES5R6*	5.6		80.0	1.17
TIS4D28QES6R8*	6.8		92.0	1.12
TIS4D28QES8R2*	8.2		98.0	1.04
TIS4D28QES100*	10.0		103	1.00
TIS4D28QES120*	12.0		128	0.84
TIS4D28QES150*	15.0		144	0.76
TIS4D28QES180*	18.0		186	0.72
TIS4D28QES220*	22.0		218	0.70
TIS4D28QES270*	27.0		252	0.58
TIS4D28QES330*	33.0		285	0.56
TIS4D28QES390*	39.0		408	0.50
TIS4D28QES470*	47.0		440	0.48
TIS4D28QES560*	56.0		550	0.41
TIS4D28QES680*	68.0		620	0.35
TIS4D28QES820*	82.0		920	0.32
TIS4D28QES101*	100	1050	0.29	
TIS4D28QES121*	120	1550	0.27	

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Part Number	L (μ H)	Test Freq. (KHz)	DCR (m Ω) Max.	Rated DC Current (A) Max.
TIS4D28QES151*	150	100	1700	0.24
TIS4D28QES151*	150		1700	0.24
TIS4D28QES181*	180		1900	0.22

Note: 1. Tolerance * : M= \pm 20%, N= \pm 30%;

2. Maximum allowable DC current is that which causes a 35% inductance reduction from the initial value, or coil temperature to rise by 40 °C, whichever is smaller (reference ambient temperature is 20°C).

Environment Characteristics

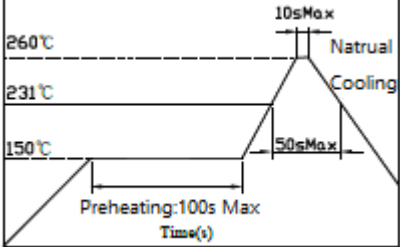
Electrical Performance Test

Item	Requirement	Test Method
L	Refer to standard electrical characteristic list.	CHP-4284A OR EQUIV.
DCR		CH-16502 OR EQUIV
Rated Current		Applied the current to coils the inductance change should be less than 35% to initial value and temperature rise should not be more than 40°C
Temperature Rise Rest	40°C Max(Δ t)	1. Applied the allowed DC current for 4 hours 2. Temperature measure by digital surface thermometer
Overload Test	No evidence of electrical damage	Applied 1.5 times of rated allowed DC current to component for a period of 5 minutes.

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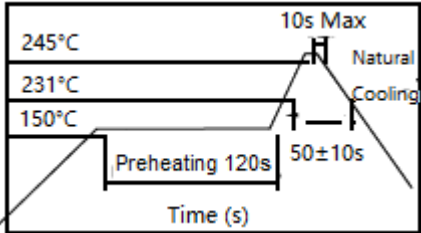
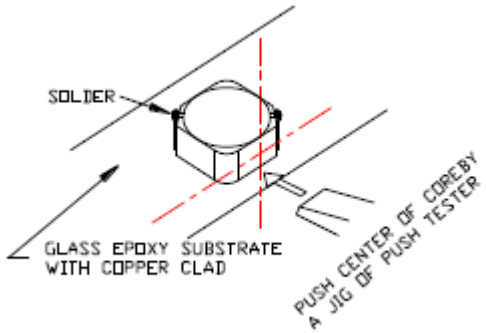
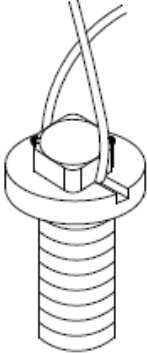
TIS4D28QES Series

Mechanical Performance Test

Item	Requirement	Test Method
Solder Heat Resistance	1. Component should have no evidence of electrical and mechanical damage. 2. Inductance should not change more than $\pm 10\%$	Preheat: 150°C 100s Max. Solder: Pb Free Solder Temperature: 260 \pm 5°C Dip time: 10s Max 
Vibration Test (Low Frequency)		1. Amplitude: 1.5mm 2. Frequency 10-55-10Hz / 1Min 3. Direction: X, Y, Z 4. Duration: 2 Hours / X, Y, Z
Shock Test		Component should be dropped 10 times from a height of 1m onto 3cm wooden board

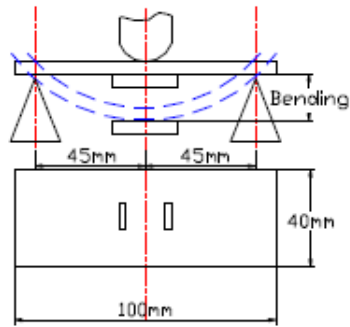
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TIS4D28QES Series

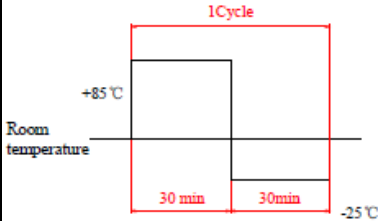
Item	Requirement	Test Method
Solderability Test	More than 90% of terminal electrode should be covered with solder	<p>Preheat: 150°C 120s Solder: Pb Free Solder Temperature: 245±5°C Dip time: 10s Max</p> 
Component Adhesion (Push Test)	1.8Kg Min.	<p>The device should be reflow soldered (232±5°C for 10 seconds) to a tinned copper substrate. A dynamometer force gauge should be applied to the side of the component. The device must withstand 0.8Kg without allure of the termination attached to component.</p> 
Component Adhesion (Pull Test)	1.8Kg Min.	<p>1. Insert 10cm wire into the remaining open eye bend the ends of even wire lengths upward and wind together. 2. Terminal shall not be remarkably damaged.</p> 

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Item	Requirement	Test Method
Flexure Strength	The forces applied should not damage the dielectric.	<p>Solder a chip on a test substrate, bend the substrate by 2 mm and return.</p> 
Resistance to Solvent Test	There should be no case deformation, change in appearance or bite ration of marking	Component shall withstand 6 minutes of alcohol.

Climatic Test

Item	Requirement	Test Method
Temperature Characteristic	1. Appearance: No damage 2. Inductance: Within $\pm 10\%$ of initial value	-40°C ~ +125°C
Humidity Test		60 ± 2 °C / 96 ± 2 hours R.H.: 90-95% R.H.
Low temperature Storage		1. Temperature: -40 ± 2 °C 2. Time: 96 ± 2 hours
Thermal Shock Test		1. -40 ± 5 °C for 30 minutes +125 ± 5 °C for 30 minutes 2. Total: 10 Cycles 
High Temperature Storage		1. Applied Max rated current 2. Temperature: 125 ± 2 °C 3. Time: 96 ± 2 hours

Note: Component are to be tested after 2 hours at room temperature

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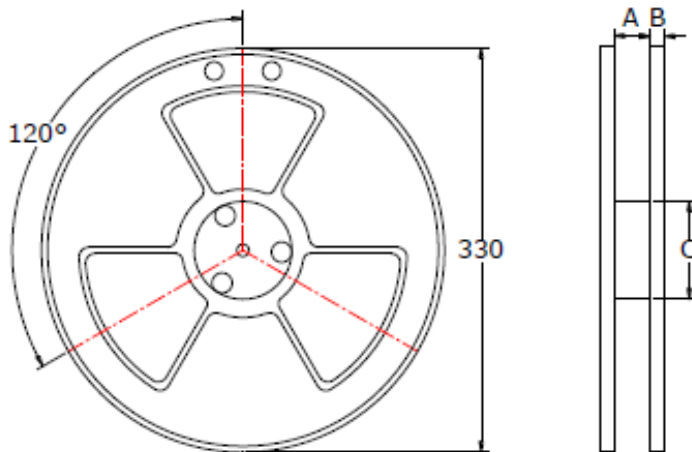
Life Test

Item	Requirement	Test Method
High Temperature Load Life Test	Component should be no evidence of short or open circuit	1. Temperature: 125±2°C 2. Time: 500±12 hours 3. Load: Allowed DC current
Humidity Load Life Test		1. Temperature: 60±2°C 2. R.H.: 90-95% R.H. 3. Time: 500±12 hours 4. Load: Allowed DC current

Packing Information:

Reel Specifications

Unit: mm

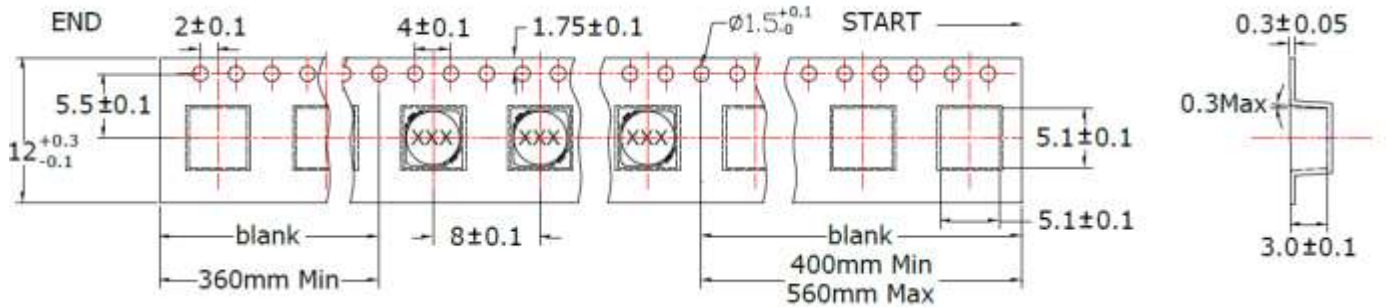


Type	A±0.1	B±0.1	C Min.
TIS4D28QES	12.5	2.3	100

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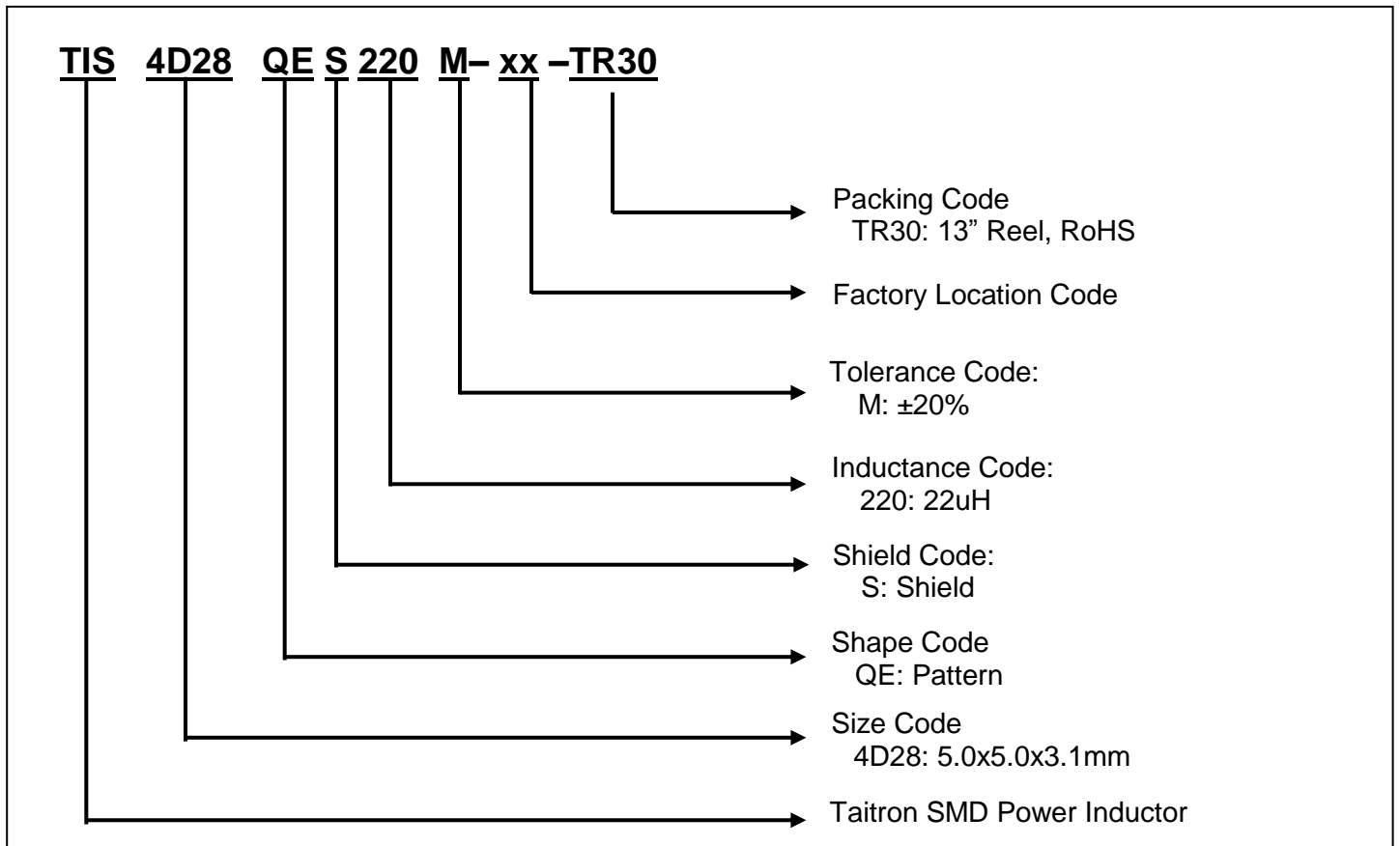
Tape Specifications



Packing Quantities:

Pcs per Reel	Pcs per Inner Box	Pcs per Shipping Carton
2,000	6,000	30,000

How to Order



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TIS4D28QES Series

How to Contact Us

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